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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/552,106 | | Applicant(s)/Patent Under Reexamination HUITEMA ET AL. | |
| | Examiner MY-CHAU T. TRAN | | Art Unit 2629 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-5,467,102 | 11-1995 | Kuno et al. | 345/1.3 |
| * | B | US-5,818,165 | 10-1998 | Malhi, Satwinder | 313/495 |
| * | C | US-6,327,482 B1 | 12-2001 | Miyashita, Toshikazu | 455/566 |
| * | D | US-6,473,072 B1 | 10-2002 | Comiskey et al. | 345/173 |
| * | E | US-6,788,292 B1 | 09-2004 | Nako et al. | 345/173 |
| * | F | US-2002/0090980 A1 | 07-2002 | Wilcox et al. | 455/566 |
| * | G | US-2005/0091431 A1 | 04-2005 | Olodort et al. | 710/072 |
| * | H | US-2005/0110702 A1 | 05-2005 | Aoki et al. | 345/030 |
| * | I | US-2006/0034039 A1 | 02-2006 | Van Rens, Bas Jan Emile | 361/681 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
|---|---|---|--|--|--|
| | U | | | | |
| | V | | | | |
| | W | | | | |
| | X | | | | |

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